

Search Notes

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10/791,751

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

TOMITA ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E23.145, E23.167, 758&774	5/15/2006	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	5/15/2006	C.C.